

1. Product profile

1.1 General description

Passivated sensitive gate 4-Q triac in a SOT54 plastic package

1.2 Features and benefits

- Direct interfacing to logic level ICs
- Direct interfacing to low power gate drive circuits
- High blocking voltage of 800V
- Sensitive gate in four quadrants

1.3 Applications

- General purpose low power motor control
- Home appliances
- Industrial process control
- Low power AC Fan controllers

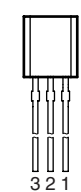
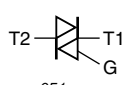
1.4 Quick reference data

Table 1. Quick reference

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
V_{DRM}	repetitive peak off-state voltage		-	-	800	V
$I_{\text{T(RMS)}}$	RMS on-state current	full sine wave; $T_{\text{lead}} \leq 38\text{ °C}$; see Figure 1 and 4	-	-	1	A
I_{TSM}	non-repetitive peak on-state current	full sine wave; $t_p = 20\text{ ms}$; $T_{\text{j(init)}} = 25\text{ °C}$; see Figure 2 and 3	-	-	8	A
		full sine wave; $t_p = 16.7\text{ ms}$; $T_{\text{j(init)}} = 25\text{ °C}$	-	-	8.5	A
Static characteristics						
I_{GT}	gate trigger current	$V_{\text{D}} = 12\text{ V}$; $T_{\text{j}} = 25\text{ °C}$; T2+ G-; see Figure 6	-	-	10	mA
		$V_{\text{D}} = 12\text{ V}$; $T_{\text{j}} = 25\text{ °C}$; T2- G-	-	-	10	mA
		$V_{\text{D}} = 12\text{ V}$; $T_{\text{j}} = 25\text{ °C}$; T2+ G+	-	-	10	mA
		$V_{\text{D}} = 12\text{ V}$; $T_{\text{j}} = 25\text{ °C}$; T2- G+	-	-	10	mA

2. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	T2	main terminal 2	 <p>SOT54 (TO-92)</p>	 <p>sym051</p>
2	G	gate		
3	T1	main terminal 1		

3. Ordering information

Table 3. Ordering information

Type number	Package		Version
	Name	Description	
Z0109NA	TO-92	plastic single-ended leaded (through hole) package; 3 leads	SOT54

4. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{DRM}	repetitive peak off-state voltage		-	800	V
$I_{T(RMS)}$	RMS on-state current	full sine wave; $T_{lead} \leq 38\text{ °C}$; see Figure 1 and 4	-	1	A
di_T/dt	rate of rise of on-state current	$I_T = 1\text{ A}$; $I_G = 20\text{ mA}$; $di_G/dt = 100\text{ mA}/\mu\text{s}$; T2+ G+	-	50	A/ μs
		$I_T = 1\text{ A}$; $I_G = 20\text{ mA}$; $di_G/dt = 100\text{ mA}/\mu\text{s}$; T2+ G-	-	50	A/ μs
		$I_T = 1\text{ A}$; $I_G = 20\text{ mA}$; $di_G/dt = 100\text{ mA}/\mu\text{s}$; T2- G-	-	50	A/ μs
		$I_T = 1\text{ A}$; $I_G = 20\text{ mA}$; $di_G/dt = 100\text{ mA}/\mu\text{s}$; T2- G+	-	20	A/ μs
I_{GM}	peak gate current		-	1	A
P_{GM}	peak gate power		-	2	W
T_{stg}	storage temperature		-40	150	°C
T_j	junction temperature		-	125	°C
I_{TSM}	non-repetitive peak on-state current	full sine wave; $t_p = 20\text{ ms}$; $T_{j(init)} = 25\text{ °C}$; see Figure 2 and 3	-	8	A
		full sine wave; $t_p = 16.7\text{ ms}$; $T_{j(init)} = 25\text{ °C}$	-	8.5	A
I^2t	I^2t for fusing	$t_p = 10\text{ ms}$; sine-wave pulse	-	0.32	A ² s
$P_{G(AV)}$	average gate power		-	0.1	W

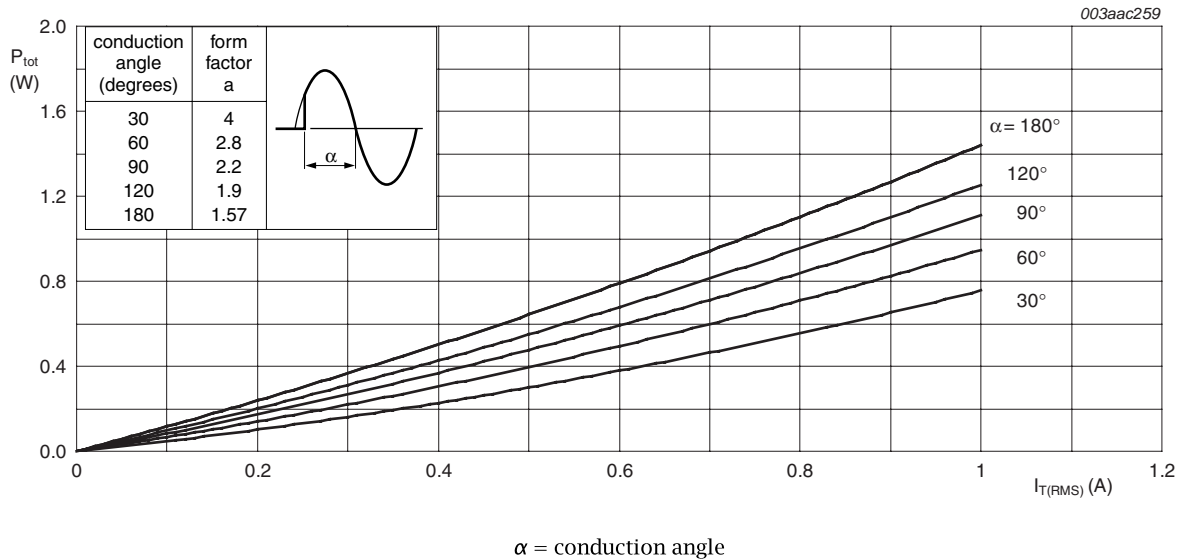


Fig 1. Total power dissipation as a function of RMS on-state current; maximum values

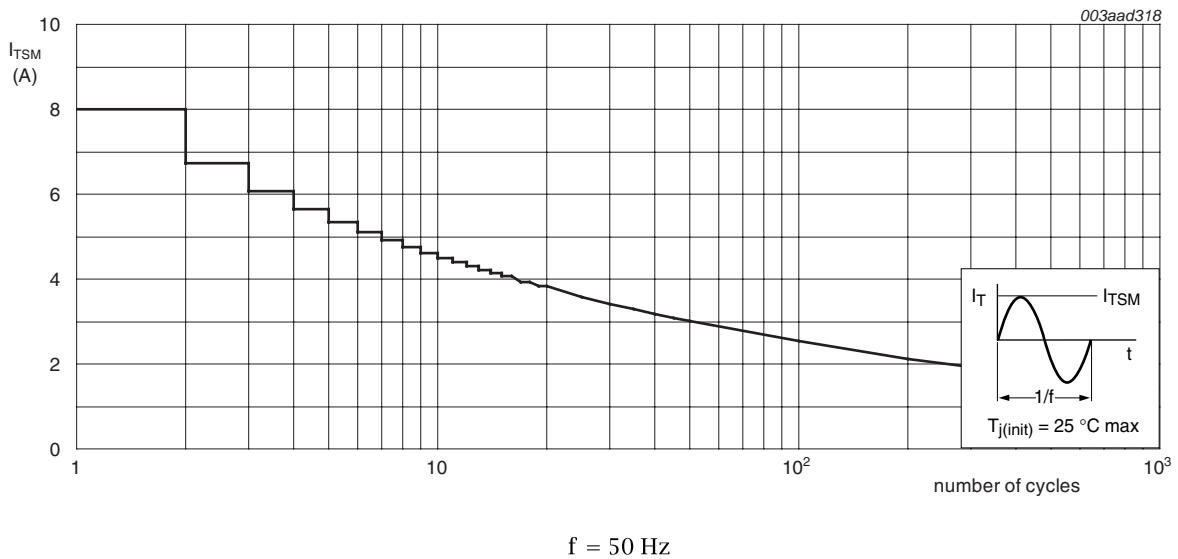
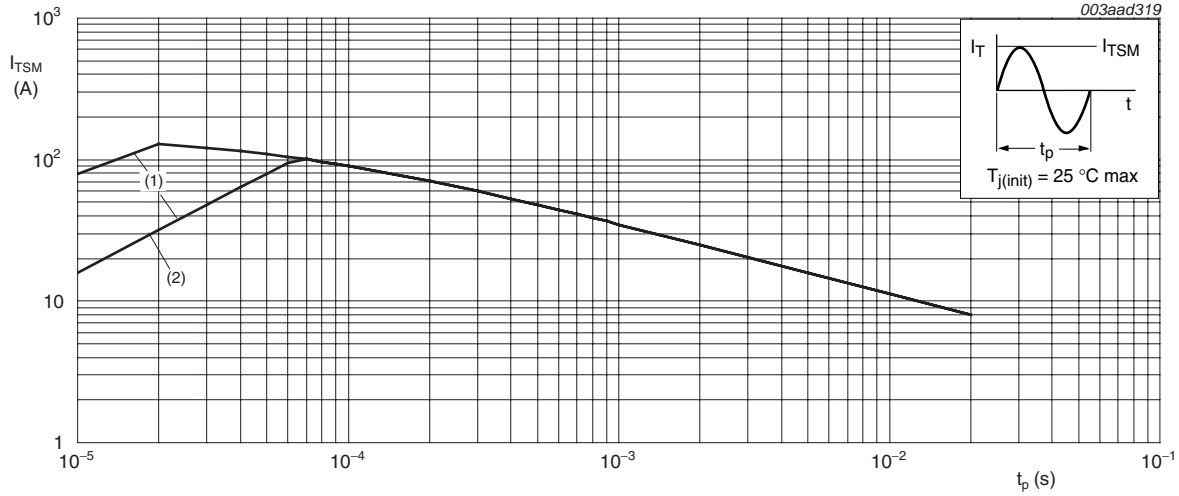


Fig 2. Non-repetitive peak on-state current as a function of the number of sinusoidal current cycles; maximum values



$t_p \leq 20\text{ ms}$; (1) is dI_T/dt limit; (2) is T2 – G + quadrant limit

Fig 3. Non-repetitive peak on-state current as a function of pulse width; maximum values

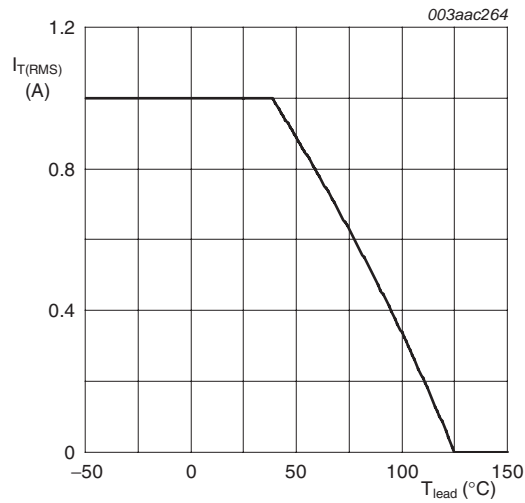


Fig 4. RMS on-state current as a function of lead temperature; maximum values

5. Thermal characteristics

Table 5. Thermal characteristics

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$R_{th(j-a)}$	thermal resistance from junction to ambient		-	150	-	K/W
$R_{th(j-lead)}$	thermal resistance from junction to lead	Full cycle; see Figure 5	-	-	60	K/W

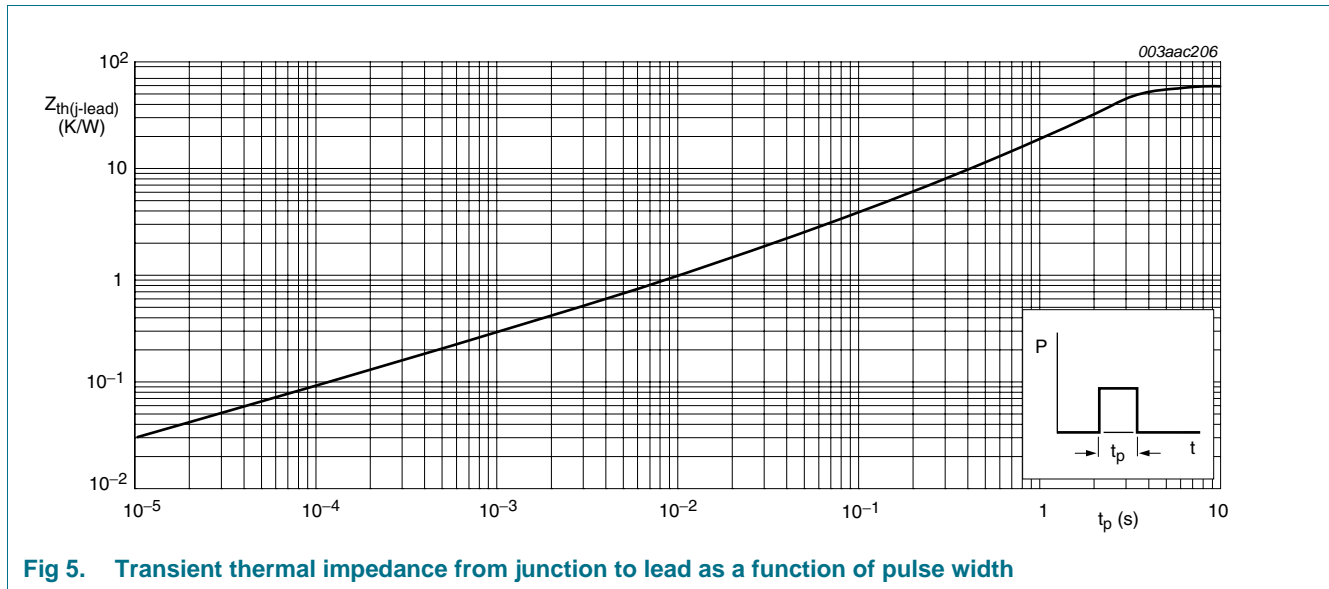
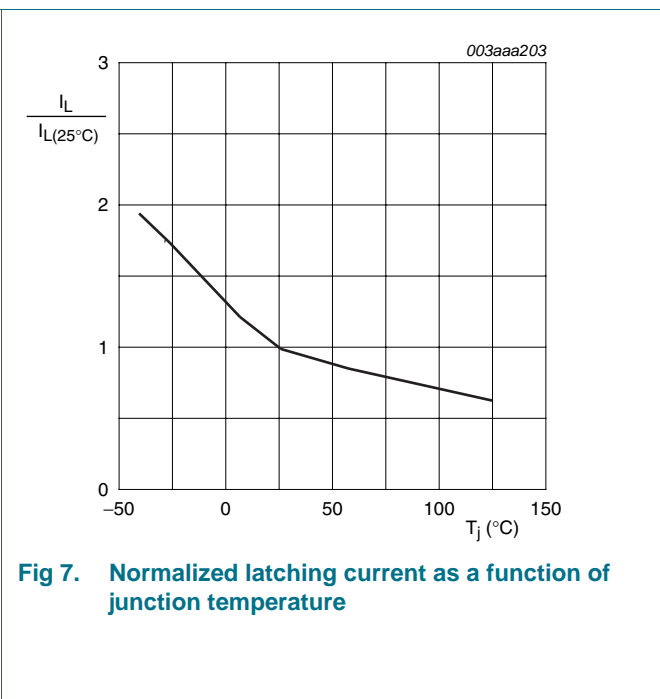
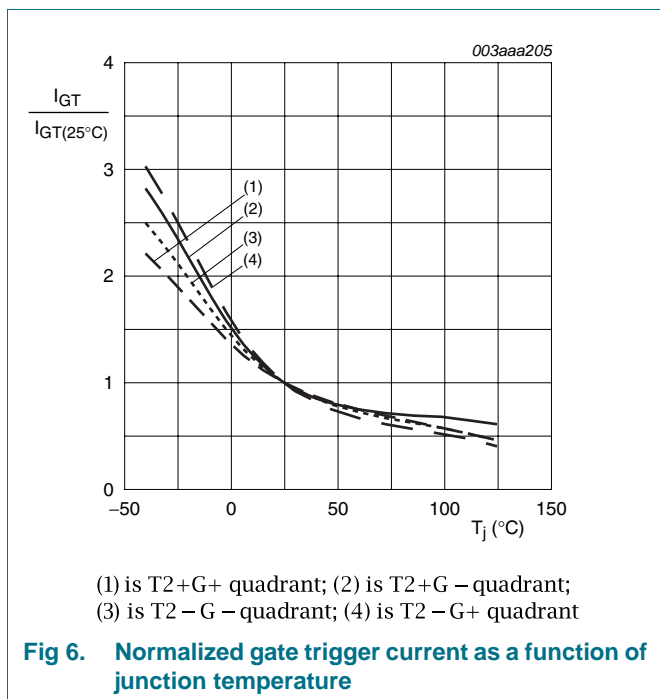


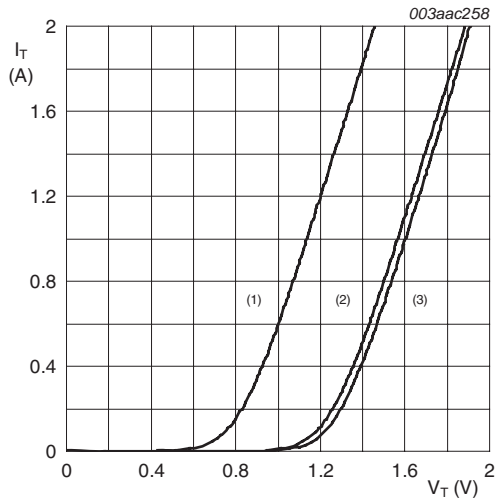
Fig 5. Transient thermal impedance from junction to lead as a function of pulse width

6. Characteristics

Table 6. Characteristics

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Static characteristics						
I_{GT}	gate trigger current	$V_D = 12\text{ V}; T_j = 25\text{ }^\circ\text{C}; T2+ G-;$ see Figure 6	-	-	10	mA
		$V_D = 12\text{ V}; T_j = 25\text{ }^\circ\text{C}; T2- G-$	-	-	10	mA
		$V_D = 12\text{ V}; T_j = 25\text{ }^\circ\text{C}; T2+ G+$	-	-	10	mA
		$V_D = 12\text{ V}; T_j = 25\text{ }^\circ\text{C}; T2- G+$	-	-	10	mA
I_L	latching current	$V_D = 12\text{ V}; T_j = 25\text{ }^\circ\text{C}; I_G = 0.1\text{ A}; T2+ G-;$ see Figure 7	-	-	25	mA
		$V_D = 12\text{ V}; T_j = 25\text{ }^\circ\text{C}; I_G = 0.1\text{ A}; T2+ G+$	-	-	15	mA
		$V_D = 12\text{ V}; T_j = 25\text{ }^\circ\text{C}; I_G = 0.1\text{ A}; T2- G+$	-	-	15	mA
		$V_D = 12\text{ V}; T_j = 25\text{ }^\circ\text{C}; I_G = 0.1\text{ A}; T2- G-$	-	-	15	mA
I_H	holding current	$V_D = 12\text{ V}; T_j = 25\text{ }^\circ\text{C};$ see Figure 10	-	-	10	mA
V_T	on-state voltage	$I_T = 1\text{ A};$ see Figure 8	-	1.3	1.6	V
V_{GT}	gate trigger voltage	$I_T = 0.1\text{ A}; V_D = 12\text{ V}; T_j = 25\text{ }^\circ\text{C};$ see Figure 9	-	-	1.3	V
		$I_T = 0.1\text{ A}; V_D = 800\text{ V}; T_j = 125\text{ }^\circ\text{C}$	0.2	-	-	V
I_D	off-state current	$V_D = 800\text{ V}; T_j = 125\text{ }^\circ\text{C}$	-	-	0.5	mA
Dynamics characteristics						
dV_D/dt	rate of rise of off-state voltage	$V_{DM} = 536\text{ V}; T_j = 110\text{ }^\circ\text{C};$ gate open circuit; see Figure 11	50	-	-	V/ μ s
dV_{com}/dt	rate of rise of commutating voltage	$V_D = 400\text{ V}; T_j = 110\text{ }^\circ\text{C}; dI_{com}/dt = 0.44\text{ A/ms};$ gate open circuit	2	-	-	V/ μ s





$V_0 = 1.254 \text{ V}; R_s = 0.31 \Omega$
 (1) $T_j = 125 \text{ }^\circ\text{C}$; typical values
 (2) $T_j = 125 \text{ }^\circ\text{C}$; maximum values
 (3) $T_j = 25 \text{ }^\circ\text{C}$; maximum values

Fig 8. On-state current as a function of on-state voltage

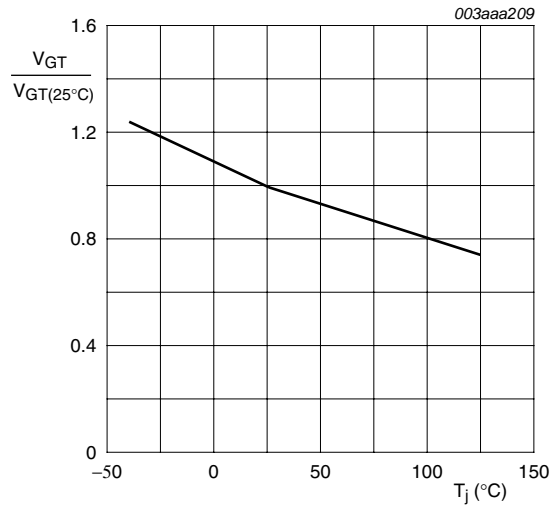


Fig 9. Normalized gate trigger voltage as a function of junction temperature

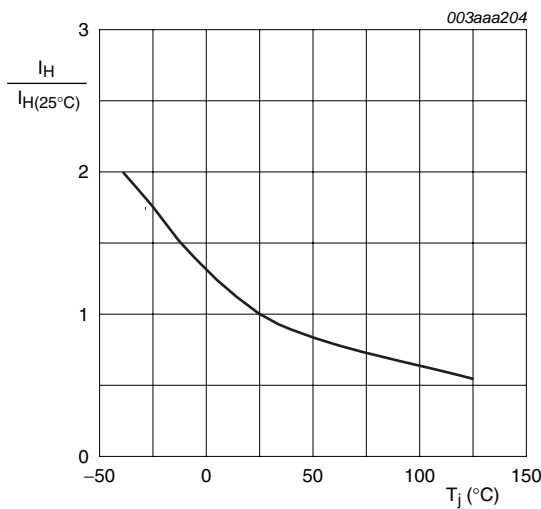
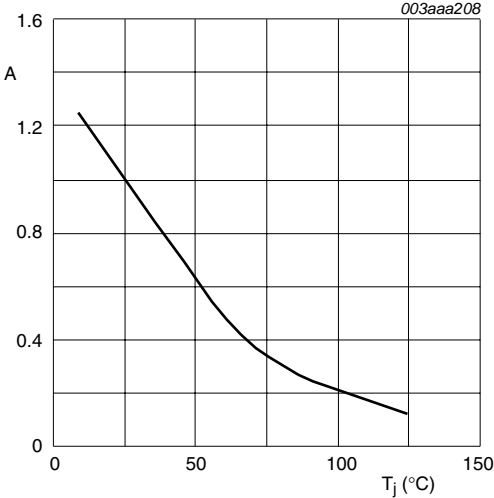


Fig 10. Normalized holding current as a function of junction temperature



$$A = \frac{dV_D/dt}{dV_{D(25^\circ\text{C})}/dt}$$

Fig 11. Normalized critical rate of rise of off-state voltage as a function of junction temperature; typical values

7. Package outline

Plastic single-ended leaded (through hole) package; 3 leads

SOT54

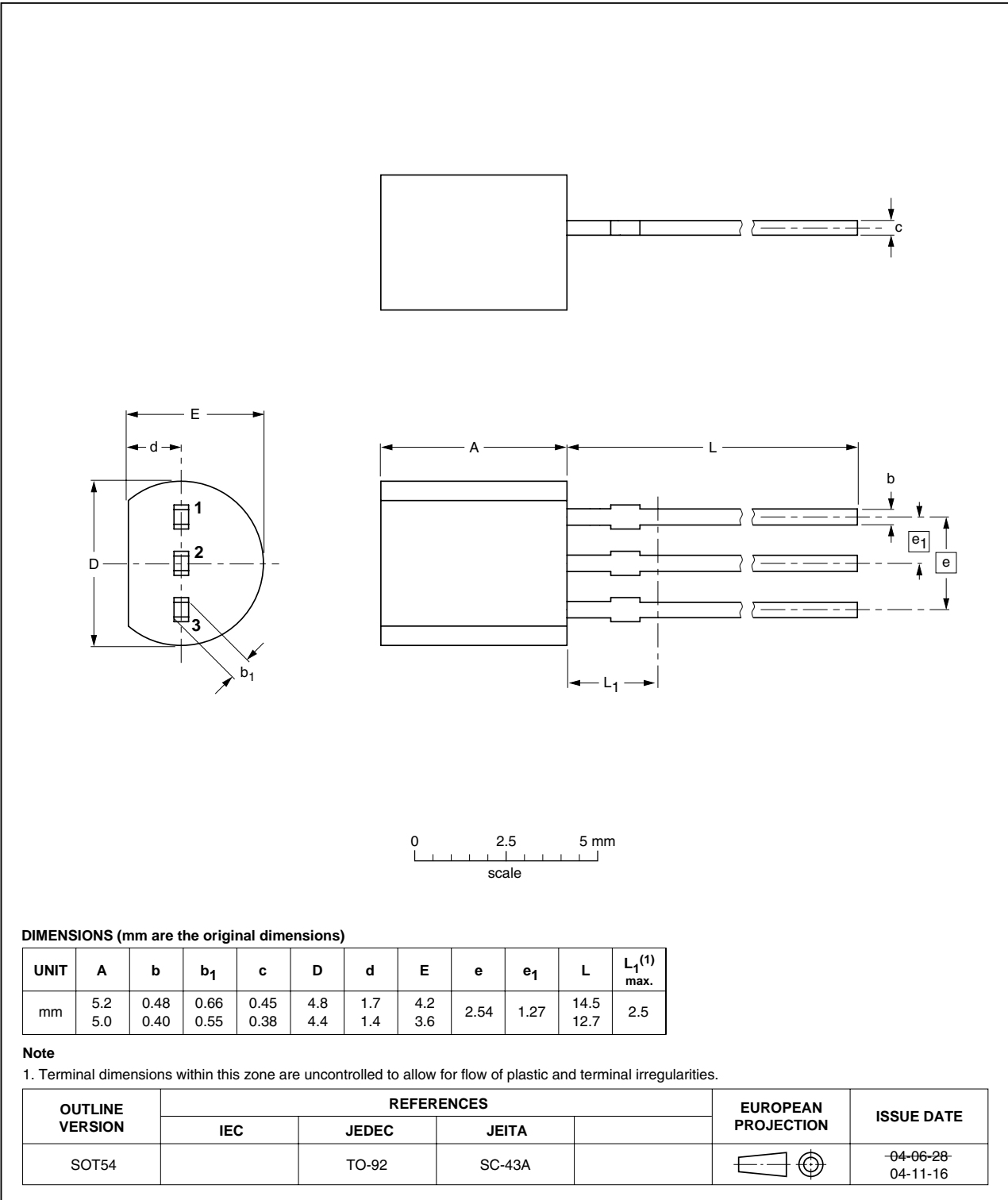


Fig 12. Package outline SOT54 (TO-92)

8. Revision history

Table 7. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
Z0109NA_4	20090804	Product data sheet	-	Z0109NA_3
Modifications:	• Various changes to content.			
Z0109NA_3	20090623	Product data sheet	-	Z0103_07_09_SERIES-02
Z0103_07_09_SERIES-02 (9397 750 10102)	20020912	Product data	-	Z0103_07_09_SERIES-01
Z0103_07_09_SERIES-01 (9397 750 09419)	20020411	Product data	-	-

9. Legal information

9.1 Data sheet status

Document status ^{[1][2]}	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

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